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| Notice of References Cited | Application/Control No. 10/659,784 | Applicant(s)/Patent Under Reexamination YEN ET AL. | |
| | Examiner Robert J. Canfield | Art Unit 3635 | Page 1 of 2 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------------|----------------|
| * | A | US-6,065,255 | 05-2000 | Stern et al. | 52/173.3 |
| * | B | US-2006/0059789 A1 | 03-2006 | Sargent, Nathan M. | 052/026 |
| * | C | US-2003/0015637 A1 | 01-2003 | Liebendorfer, John E. | 248/237 |
| * | D | US-5,067,685 | 11-1991 | Johnston, Jr., Robert G. | 248/676 |
| * | E | US-5,820,092 | 10-1998 | Thaler, Ken | 248/237 |
| * | F | US-2005/0217665 A1 | 10-2005 | Luconi, Gregg Frederick | 126/696 |
| * | G | US-2004/0123862 A1 | 07-2004 | Hay, Harold R. | 126/621 |
| * | H | US-2003/0010372 A1 | 01-2003 | Dinwoodie, Thomas L. | 136/244 |
| * | I | US-2003/0177705 A1 | 09-2003 | Forbis et al. | 52/3 |
| * | J | US-5,571,338 A | 11-1996 | Kadonome et al. | 136/251 |
| * | K | US-2004/0011354 A1 | 01-2004 | Erling, Peter Stuart | 126/621 |
| * | L | US-2005/0166955 A1 | 08-2005 | Nath et al. | 136/251 |
| * | M | US-6,617,507 B2 | 09-2003 | Mapes et al. | 136/251 |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
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NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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|-----------------------------------|---------------------------------------|---|-------------|
| Notice of References Cited | Application/Control No. 10/659,784 | Applicant(s)/Patent Under Reexamination YEN ET AL. | |
| | Examiner Robert J. Canfield | Art Unit 3635 | Page 2 of 2 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------------|----------------|
| * | A | US-5,125,608 | 06-1992 | McMaster et al. | 248/163.1 |
| * | B | US-4,125,978 | 11-1978 | Schildge, Jr., Adam T. | 52/223.1 |
| * | C | US-748,440 | 12-1903 | Jackson | 131/313 |
| | D | US- | | | |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
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